Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/784,950	KAMIYA ET AL.	
Examiner	Art Unit	_
Patrick H. Mackey	3651	

SEARCHED			
Class	Subclass	Date	Examiner
271	220		
	221		
	222	,	
270	58.11		
	58.12		
	58.16		
	58.17	7/15/2005	РНМ
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INTERFERENCE SEARCHED			
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SEARCH (INCLUDING SEAF	NOTES RCH STRATEG	Y)
	DATE	EXMR
Plus Search	7/15/2005	РНМ
Text Search	7/15/2005	РНМ
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